

Application/Control N	o. Applicant(s)/Patent under Reexamination
10/759,909	RAISANEN, HEIKKI EERO
Examiner	Art Unit
Marlon T. Fletcher	2837

SEARCHED				
Class	Subclass	Date	Examiner	
		-		
	A			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		<del></del>			
	1				

SEARCH NOT (INCLUDING SEARCH S		)
	DATE	EXMR
EAST TEXT SEARCH: SEE SEARCH HISTORY PRINTOUT	8/6/2006	MTF
_		